## Description

The F1451 is a High Gain / High Linearity 450MHz to 1100MHz TX Digital Variable Gain Amplifier used in transmitter applications.

The F1451 TX DVGA provides 32dB maximum gain with +41.5 dBm OIP3 and 3.6 dB noise figure. Up to 29.5 dB gain control is achieved using the combination of a digital step attenuator (DSA) and a $K_{L w^{T M}}$ RF Digital Gain Amplifier. This device uses a single 5 V supply and 185 mA of Icc.

This device is packaged in a $6 \times 6 \mathrm{~mm}$, 28-pin VFQFPN with $50 \Omega$ single-ended RF input and RF output impedances for ease of integration into the signal-path.

## Competitive Advantage

In typical Base Stations, RF VGAs are used in the TX traffic paths to drive the transmit power amplifier. The F1451 TX DVGA offers very high reliability due to its construction from a monolithic silicon die in a QFN package. The F1451 is configured to provide an optimum balance of noise and linearity performance consisting of a $K_{L I T^{T M}}$ RF amplifier, digital step attenuator (DSA) and a PA driver amplifier. The $K_{L N}{ }^{\top M}$ amplifier maintains the OIP3 and output P1dB performance over an extended attenuation range when compared to competitive devices.

## Typical Applications

- Multi-mode, Multi-carrier Transmitters
- WiMAX and LTE Base Stations
- UMTS/WCDMA 3G Base Stations
- PHS/PAS Base Stations
- Public Safety Infrastructure


## Features

- Broadband 450 MHz to 1100 MHz
- 32dB maximum gain
- 3.6 dB NF at maximum gain $(900 \mathrm{MHz}$ )
- 29.5 dB total gain control range, 0.5 dB step
- <2dB overshoot between gain transitions
- Maintains flat +23 dBm OP1dB for more than 13dB gain adjustment range
- Maintains flat +41 dBm OIP3 for more than 15 dB gain adjustment range
- SPI interface for DSA control
- Single 5 V supply voltage
- $\mathrm{Icc}_{\mathrm{cc}}=185 \mathrm{~mA}$
- Up to $+105^{\circ} \mathrm{C} T_{\text {CASE }}$ operating temperature
- $50 \Omega$ input and output impedance
- Standby mode for power savings
- Pin compatible 2100 MHz and 2700 MHz versions
- $6 \times 6 \mathrm{~mm}, 28$-VFQFPN package


## Block Diagram

Figure 1. Block Diagram


## Pin Assignments

Figure 2. Pin Assignments for $6 \times 6 \times 0.9 \mathrm{~mm}$ QFN Package - Top View


## Pin Descriptions

Table 1. Pin Descriptions

| Number | Name | Description |
| :---: | :---: | :---: |
| 1 | CSb | Chip select input: 1.8 V or 3.3 V logic compatible. |
| 2 | DATA | Data input: 1.8 V or 3.3 V logic compatible. |
| 3 | CLK | Clock input: 1.8 V or 3.3 V logic compatible. |
| 4 [a] | RSET | Connect 2.0k』 external resistor to GND to set amplifier bias. |
| $\begin{gathered} \hline 5,7,15,17, \\ 21,23,27 \end{gathered}$ | GND | Pins internally tied to exposed paddle. Connect to ground on PCB. |
| 6 | RFIN | RF input internally matched to $50 \Omega$. Must use external DC block. |
| $\begin{gathered} \hline 8,9,10,11, \\ 12,13,18, \\ 19,20,22, \\ 24,25,26 \end{gathered}$ | NC | No internal connection. These pins can be left unconnected, voltage applied, or connected to ground (recommended). |
| 14 | ISTBY | Standby pin. Device will be placed in standby mode when pin 14 is set to a logic low or when pin 14 is left floating (pulled low via internal high impedance to GND). In standby mode, SPI circuitry is still active. With a logic high applied to pin 14 the part is set to full operation mode. |
| 16 | RFOUT | RF output internally matched to $50 \Omega$. Must use external DC block. |
| 28 | VCC | 5 V Power Supply. Connect to $\mathrm{V}_{\mathrm{cc}}$ and use bypass capacitors as close to the pin as possible. |
|  | EP | Exposed Pad. Internally connected to GND. Solder this exposed pad to a PCB pad that uses multiple ground vias to provide heat transfer out of the device into the PCB ground planes. These multiple vias are also required to achieve the noted RF performance. |

a. External resistor on pin 4 used to optimize the overall device for DC current and linearity performance across the entire frequency band.

## Absolute Maximum Ratings

Stresses above those listed below may cause permanent damage to the device. Functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 2. Absolute Maximum Ratings

| Parameter | Symbol | Minimum | Maximum | Units |
| :--- | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {cc }}$ to GND | $\mathrm{V}_{\mathrm{CC}}$ | -0.5 | 5.5 | V |
| DATA, CSb, CLK, /STBY | $\mathrm{V}_{\mathrm{Cntrl}}$ | -0.3 | $\mathrm{~V}_{\mathrm{CC}}$ | V |
| RSET | $\mathrm{I}_{\text {RSET }}$ |  | +1.5 | mA |
| RFIN externally applied DC voltage | $\mathrm{V}_{\text {RFIN }}$ | +1.4 | +3.6 | V |
| RFOUT externally applied DC voltage | $\mathrm{V}_{\text {RFout }}$ | $\mathrm{V}_{\mathrm{CC}}-0.15$ | $\mathrm{~V}_{\mathrm{CC}}+0.15$ | V |
| RF Input Power (RFIN) applied for 24 hours max. [a] | $\mathrm{P}_{\text {max_in }}$ |  | +12 | dBm |
| Continuous Power Dissipation | $\mathrm{P}_{\text {diss }}$ |  | 1.75 | W |
| Junction Temperature | $\mathrm{T}_{\mathrm{j}}$ |  | 150 | ${ }^{\circ} \mathrm{C}$ |
| Storage Temperature Range | $\mathrm{T}_{\mathrm{st}}$ | -65 | 150 | ${ }^{\circ} \mathrm{C}$ |
| Lead Temperature (soldering, 10s) |  |  | 260 | ${ }^{\circ} \mathrm{C}$ |
| ElectroStatic Discharge - HBM <br> (JEDEC/ESDA JS-001-2012) |  |  | 2000 <br> (Class 2) | $\mathrm{V}^{\mathrm{V}}$ |
| ElectroStatic Discharge - CDM <br> (JEDEC 22-C101F) |  | 1000 <br> (Class C3) | V |  |

a. Exposure to these maximum RF levels can result in significantly higher $\mathrm{I}_{\mathrm{cc}}$ current draw due to overdriving the amplifier stages.

## Recommended Operating Conditions

## Table 3. Recommended Operating Conditions

| Parameter | Symbol | Condition | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Power Supply Voltage | $V_{\text {cc }}$ |  | 4.75 |  | 5.25 | V |
| Operating Temperature Range | TCASE | Exposed Paddle | -40 |  | +105 | ${ }^{\circ} \mathrm{C}$ |
| RF Frequency Range ${ }^{\text {[a] }}$ | $\mathrm{F}_{\mathrm{RF}}$ | High Linearity Bandwidth | 450 |  | 1100 | MHz |
|  |  | Extended band for DPD | 440 |  | 1200 |  |
| Maximum Operating Average RF Output Power |  | $\mathrm{Z}_{\mathrm{S}}=\mathrm{Z}_{\mathrm{L}}=50 \Omega$ |  |  | 14 | dBm |
| RFIN Port Impedance | $\mathrm{Z}_{\text {RFI }}$ | Single-ended |  | 50 |  | $\Omega$ |
| RFOUT Port Impedance | $Z_{\text {RFO }}$ | Single-ended |  | 50 |  | $\Omega$ |

a. Device linearity is optimized over the range from 450 MHz to 1100 MHz . Gain flatness is optimized from 600 MHz to 1200 MHz to account for systems with extended DPD bandwidth requirements.

## Electrical Characteristics - General

See Typical Application Circuit. Unless otherwise stated, specifications apply when operated as a TX VGA, $V_{C C}=+5.0 \mathrm{~V}, \mathrm{~F}_{\mathrm{RF}}=806 \mathrm{MHz}$, $\mathrm{T}_{\text {CASE }}=+25^{\circ} \mathrm{C}, / \mathrm{STBY}=$ High, $\mathrm{Z}_{\mathrm{S}}=\mathrm{Z}_{\mathrm{L}}=50 \Omega$, maximum gain setting. Evaluation Kit trace and connector losses are de-embedded.
Table 4. Electrical Characteristics

| Parameter | Symbol | Condition | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Logic Input High Threshold | $\mathrm{V}_{\text {IH }}$ | JEDEC 1.8V or 3.3V logic | $1.1{ }^{\text {[a] }}$ |  | $V_{c c}$ | V |
| Logic Input Low Threshold | $\mathrm{V}_{\text {IL }}$ | JEDEC 1.8V or 3.3V logic | -0.3 |  | 0.8 | V |
| Logic Current | $\mathrm{l}_{\mathrm{H},} \mathrm{I}_{\text {IL }}$ | SPI | -1 |  | +1 | $\mu \mathrm{A}$ |
|  | $\mathrm{I}_{\text {STBY }}$ | ISTBY | -10 |  | +10 |  |
| DC Current | ICC |  |  | 185 | 215 | mA |
| Standby Current | ICC_STBY | /STBY = LOW |  | 1 | 2 | mA |
| Standby Switching Time | TSTBY | 50\% /STBY control to within 0.2 dB of the on state final gain value |  | 250 |  | ns |
| Gain Step | $\mathrm{G}_{\text {Step }}$ | Least significant bit |  | 0.5 |  | dB |
| Maximum Attenuator Glitching | $\mathrm{ATTNG}_{\text {G }}$ | Any state to state transition |  | 2 |  | dB |
| Maximum Step Error (DNL) [over voltage, temperature and attenuation states] | $\mathrm{ERROR}_{\text {step }}$ | $\mathrm{F}_{\mathrm{RF}}=0.700 \mathrm{GHz}$ | -0.09 |  | +0.12 | dB |
|  |  | $\mathrm{F}_{\mathrm{RF}}=0.806 \mathrm{GHz}$ | -0.08 | 0.10 | +0.12 |  |
|  |  | $\mathrm{F}_{\mathrm{RF}}=0.900 \mathrm{GHz}$ | -0.09 |  | +0.14 |  |
|  |  | $\mathrm{F}_{\mathrm{RF}}=1.000 \mathrm{GHz}$ | -0.10 |  | +0.15 |  |
|  |  | $\mathrm{F}_{\mathrm{RF}}=1.100 \mathrm{GHz}$ | -0.10 |  | +0.15 |  |
| Maximum Absolute Error (INL) | $\mathrm{ERROR}_{\text {abs }}$ | Over attenuation range referenced to max gain state |  | 1.2 |  | dB |
| Gain Settling Time [c] | $\mathrm{G}_{\text {ST }}$ | 50\% of CSb to 10\% / 90\% RF |  | 200 |  | ns |
| SPI [d] |  |  |  |  |  |  |
| Serial Clock Speed | Fclock |  |  |  | 25 | MHz |
| CSb to CLK Setup Time | TLS |  | 5 |  |  | ns |
| CLK to Data Hold Time | $\mathrm{TH}_{\mathrm{H}}$ |  | 5 |  |  | ns |
| CSb Trigger to CLK Setup Time | TLC |  | 5 |  |  | ns |

a. Items in min/max columns in bold italics are guaranteed by test.
b. Items in min/max columns that are not bold/italics are guaranteed by design characterization.
c. Excludes SPI write time.
d. SPI 3 wire bus (refer to serial Control Mode Timing diagram).

## Electrical Characteristics - RF

See Typical Application Circuit. Unless otherwise stated, specifications apply when operated as a TX VGA, $V_{C C}=+5.0 \mathrm{~V}, \mathrm{~F}_{\mathrm{RF}}=806 \mathrm{MHz}$, $\mathrm{T}_{\text {CASE }}=+25^{\circ} \mathrm{C}$, $/ \mathrm{STBY}=$ High, $\mathrm{Z}_{\mathrm{S}}=\mathrm{Z}_{\mathrm{L}}=50 \Omega$, maximum gain setting. Evaluation Kit trace and connector losses are de-embedded

Table 5. Electrical Characteristics

| Parameter | Symbol | Condition | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| RF Input Return Loss | RLRFIN |  |  | 20 |  | dB |
| RF Output Return Loss | RLrfout |  |  | 15 |  | dB |
| Gain - Max Gain Setting | $\mathrm{G}_{\text {max }}$ |  | 30.6 [ ${ }^{\text {] }}$ | 32.1 | 33.6 | dB |
| Gain - Min Gain Setting | $\mathrm{G}_{\text {min }}$ | Max attenuation | 0.0 | 1.5 | 3.0 | dB |
| Gain Flatness [c] | $\mathrm{G}_{\text {fLat }}$ | $\mathrm{F}_{\mathrm{RF}}=700 \mathrm{MHz}$ to 1100 MHz |  | 0.7 |  | dB |
| Noise Figure | NF | OdB attenuation |  | 3.6 |  | dB |
|  |  | 10dB attenuation |  | 6.0 |  |  |
|  |  | 20 dB attenuation |  | 11.6 |  |  |
|  |  | 29.5 dB attenuation |  | 20.6 |  |  |
| Output Third Order Intercept Point | OIP3 | OdB attenuation <br> Pout $=+7 \mathrm{dBm} /$ tone <br> 5 MHz tone separation |  | 41.5 |  | dBm |
|  |  | 6dB attenuation <br> Pin $=-21 \mathrm{dBm} /$ tone <br> 5 MHz tone separation |  | 41.3 |  |  |
|  |  | 10dB attenuation Pin $=-21 \mathrm{dBm} /$ tone 5 MHz tone separation | 37 | 40.7 |  |  |
|  |  | 20 dB attenuation Pin =-21dBm / tone 5 MHz tone separation |  | 37.8 |  |  |
|  |  | 29.5dB attenuation Pin $=-21 \mathrm{dBm} /$ tone 5 MHz tone separation |  | 29.8 |  |  |
| Output 1dB Compression Point | OP1dB | OdB attenuation |  | 23.5 |  | dBm |
|  |  | 0 dB attenuation, $T_{\text {CASE }}=+105^{\circ} \mathrm{C}$ |  | 23 |  |  |
|  |  | 6 dB attenuation | 21.8 | 23.5 |  |  |

a. Items in min/max columns in bold italics are guaranteed by test.
b. Items in min/max columns that are not bold/italics are guaranteed by design characterization.
c. Includes a positive slope feature over the noted RF range to compensate for typical system roll-off.

## Thermal Characteristics

Table 6. Package Thermal Characteristics

| Parameter | Symbol | Value | Units |
| :--- | :---: | :---: | :---: |
| Junction to Ambient Thermal Resistance | $\theta_{\mathrm{JA}}$ | 40 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Junction to Case Thermal Resistance <br> (Case is defined as the exposed paddle) | $\theta_{\mathrm{JC}}$ | 4 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Moisture Sensitivity Rating (Per J-STD-020) |  | MSL 1 |  |

## Typical Operating Conditions (TOC)

Unless otherwise stated the typical operating graphs were measured under the following conditions:

- $\mathrm{V}_{c c}=5.0 \mathrm{~V}$
- $Z_{L}=Z_{S}=50 \Omega$ Single-ended
- $\mathrm{F}_{\mathrm{RF}}=806 \mathrm{MHz}$
- $\mathrm{T}_{\text {CASE }}=+25^{\circ} \mathrm{C}$
- ISTBY = High
- 5 MHz Tone Spacing
- Gain setting = Maximum Gain
- Output Power $=+7 \mathrm{dBm} /$ tone for OIP3
- All temperatures are referenced to the exposed paddle
- ACLR measurements used with a Basic LTE FDD Downlink 20MHz TM1.2 Test signal
- EVM measurements used with a Basic LTE FDD Downlink 20MHz TM3.1 Test signal
- Note TN1: Atten $\leq 4 \mathrm{~dB}$ Fixed Pout $=+7.0 \mathrm{dBm}$ per waveform or per tone, Atten $>4 \mathrm{~dB}$ Fixed Pin $=-21 \mathrm{dBm}$ per waveform or per tone
- Note TN2: Atten $\leq 7 \mathrm{~dB}$ Fixed Pout $=+10.5 \mathrm{dBm}$ per waveform or per tone, Atten $>7 \mathrm{~dB}$ Fixed Pin $=-14.5 \mathrm{dBm}$ per waveform or per tone
- Evaluation Kit traces and connector losses are de-embedded


## Typical Performance Characteristics

Figure 3. Maximum Gain vs. Frequenc y over Temp and Voltage [Attn $=0.0 \mathrm{~dB}$ ]


Figure 5. Input Return Loss vs. Frequency over Temp and Voltage [Attn =0.0dB]


Figure 4. Reverse Isolation vs. Frequency over Temp and Voltage [Attn $=0.0 \mathrm{~dB}$ ]


Figure 6. Output Return Loss vs. Frequency over Temp and Voltage [Attn =0.0dB]


Figure 7. Stability vs. Frequency over Temperature and Voltage [Attn $=0.0 \mathrm{~dB}$ ]


Figure 9. Gain vs. Frequency [ $+25^{\circ} \mathrm{C}$, All States]


Figure 11. Worse Case Attenuator Absolute Accuracy vs. Freq [All parameters]


Figure 8. EvKit Insertion Loss vs. Frequency over Temperature


Figure 10. Gain vs. Attenuation over
Temperature and Voltage [806MHz]


Figure 12. Attenuator Absolute Accuracy vs. Atten over Temp and Voltage [806MHz]


Figure 13. Worse Case Step Accuracy vs. Freq [All parameters]


Figure 15. Input Return Loss vs. Frequency [ $+25^{\circ} \mathrm{C}$, All states]


Figure 17. Output Return Loss vs. Frequency [ $+25^{\circ} \mathrm{C}$, All states]


Figure 14. Step Accuracy vs. Attenuation over Temperature and Voltage [806MHz]


Figure 16. Input Return Loss vs. Attenuation over Temperature and Voltage [806MHz]


Figure 18. Output Return Loss vs. Attenuation over Temperature and Voltage [806MHz]


Figure 19. Reverse Isolation vs. Frequency [+25 ${ }^{\circ}$, All states]


Figure 21. Output IP3 vs. Attn over Temp and Voltage [700MHz] (Test Note TN1)


Figure 23. Output IP3 vs. Attn over Temp and Voltage [900MHz] (Test Note TN1)


Figure 20. Reverse Isolation vs. Attenuation over Temperature and Voltage [806MHz]


Figure 22. Output IP3 vs. Attn over Temp and Voltage [700MHz] (Test Note TN2)


Figure 24. Output IP3 vs. Attn over Temp and Voltage [900MHz] (Test Note TN2)


Figure 25. Output IP3 vs. Attn over Temp and Voltage [1100MHz] (Test Note TN1)


Figure 27. Output IP3 vs. Frequency over Temperature and Voltage [Attn =0.0dB]


Figure 29. Output PldB vs. Frequency over Temp and Voltage [Attn $=0.0 \mathrm{~dB}$ ]


Figure 26. Output IP3 vs. Attn over Temp and Voltage [1100MHz] (Test Note TN2)


Figure 28. Output P1dB vs. Attenuation over Temperature and Voltage [700MHz]


Figure 30. Output P1dB vs. Attenuation over Temp and Voltage [900MHz]


Figure 31. Output P1dB vs. Attenuation over Temp and Voltage [1100MHz]


Figure 33. Noise Figure vs. Attenuation over Temperature and Voltage [700MHz]


Figure 35. Noise Figure vs. Attenuation over Temperature and Voltage [1100MHz]


Figure 32. Noise Figure vs. Frequency over Temperature and Voltage [Attn $=0.0 \mathrm{~dB}$ ]


Figure 34. Noise Figure vs. Attenuation over Temperature and Voltage [900MHz]


Figure 36. Switching Speed 0.0dB to 29.5dB


Figure 38. Switching Speed Standby Mode to Full Operation Mode


Figure 37. Switching Speed 29.5dB to 0.0dB


Figure 39. Switching Speed Full Operation Mode to Standby Mode


Figure 40. ACLR vs. Attenuation [700MHz]


Figure 42. ACLR vs. Attenuation [900MHz]


Figure 44. ACLR vs. Attenuation [1100MHz]


Figure 41. EVM vs. Attenuation [700MHz]


Figure 43. EVM vs. Attenuation [900MHz]


Figure 45. EVM vs. Attenuation [1100MHz]


## Serial Port Interface

Serial data is formatted as a 6 -bit word clocking data in MSB first.
Table 7. Attenuation Word Truth Table

| Control Bit |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| D5 | D4 | D3 | D2 | D1 | D0 | Attenuator Setting ${ }^{[a]}$ |
| 1 | 1 | 1 | 1 | 1 | 1 | 0.0 dB |
| 1 | 1 | 1 | 1 | 1 | 0 | 0.5 dB |
| 1 | 1 | 1 | 1 | 0 | 1 | 1.0 dB |
| 1 | 1 | 1 | 0 | 1 | 1 | 2.0 dB |
| 1 | 1 | 0 | 1 | 1 | 1 | 4.0 dB |
| 1 | 0 | 1 | 1 | 1 | 1 | 8.0 dB |
| 0 | 1 | 1 | 1 | 1 | 1 | 16.0 dB |
| 0 | 0 | 0 | 1 | 0 | 0 | 29.5 dB |
| 0 | 0 | 0 | 0 | 1 | 1 | 29.5 dB |
| 0 | 0 | 0 | 0 | 1 | 0 | 29.5 dB |
| 0 | 0 | 0 | 0 | 0 | 1 | 29.5 dB |
| 0 | 0 | 0 | 0 | 0 | 0 | 29.5 dB |

a. The attenuation setting is designed to operate from $0 \mathrm{~dB}(111111)$ to 29.5 dB (000100).

Figure 46. Serial Register Timing Diagram
CLK (pin 3)


DATA (pin 2)

CSb (pin 1)


Clock in MSB first


Figure 47. SPI Timing Diagram


Table 8. SPI Timing Diagram Values for Figure 53

| Parameter | Symbol | Test Condition | Min | Typ | Max | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CLK Frequency | $\mathrm{F}_{\mathrm{C}}$ |  |  |  | 25 | MHz |
| CLK High Duration Time | $\mathrm{T}_{\mathrm{CH}}$ |  | 20 |  |  | ns |
| CLK Low Duration Time | $\mathrm{T}_{\mathrm{CL}}$ |  | 20 |  |  | ns |
| DATA to CLK Setup Time | $\mathrm{T}_{\mathrm{S}}$ |  | 5 |  |  | ns |
| CLK Period [a] | $\mathrm{T}_{\mathrm{P}}$ |  | 40 |  |  | ns |
| CLK to DATA Hold Time | $\mathrm{T}_{\mathrm{H}}$ |  | 5 |  |  | ns |
| CSb to CLK Setup Time | $\mathrm{T}_{\mathrm{LS}}$ |  | 5 |  |  | ns |
| CSb Trigger Pulse Width | $\mathrm{T}_{\mathrm{L}}$ |  | 10 |  |  | ns |
| CSb Trigger to CLK Setup Time [b] | $\mathrm{T}_{\mathrm{LC}}$ |  | 5 |  |  | ns |

a. $\left(T_{C H}+T_{C L}\right) \geq 1 / F_{C}$
b. Once all desired DATA is clocked in, TLc represents the time a CSb high needs to occur before any subsequent CLK signals.

Table 9. Standby Truth Table

| ISTBY (pin 14) | Condition |
| :---: | :--- |
| 0 V | Amplifier OFF with SPI powered ON |
| $\mathrm{V}_{c c}$ | Full operation |

## Applic ation Information

The F1451 has been optimized for use in high performance RF applications from 450 MHz to 1100 MHz but in general has a much wider band which is shown in the Typical Performance Characteristics.

## Power Up Attenuation Setting

When the part is initially powered up, the default VGA setting is the 29.5dB [000000] attenuation state.

## Chip Select (CSb)

When CSb is set to logic high, the CLK input is disabled. When CSb is set to logic low, the CLK input is enabled and the DATA word can be programmed into the shift registers. The programmed word is then latched into the F1451 on the CSb rising edge (refer to Figure 53). The operation of the SPI bus in independent of the /STBY pin setting (see Standby Mode section below).

## Standby Mode (/STBY)

The F1451 has a power down feature for power savings which is on Pin 14. For normal operation pin 14 must be set to a logic high. When a logic low is applied to pin 14 the amplifier is placed in standby mode. The Standby mode is a high isolation state. The level of this isolation is not specified and is dependent on the device and attenuation state. In Standby mode the SPI bus is operational and the device attenuation setting can be programmed. Therefore, the device will present the desired attenuation when it is enabled.

## Power Supplies

A common $V_{c c}$ power supply should be used for all power supply pins. To minimize noise and fast transients de-coupling capacitors to all supply pins. Supply noise can degrade noise figure and fast transients can trigger ESD clamps causing them to fail. Supply voltage change or transients should have a slew rate smaller than $1 \mathrm{~V} / 20 \mu \mathrm{~s}$. In addition, all control pins should remain at $0 \mathrm{~V}( \pm 0.3 \mathrm{~V})$ while the supply voltage ramps or while it returns to zero.

## Control Pin Interface

If control signal integrity is a concern and clean signals cannot be guaranteed due to overshoot, undershoot, ringing, etc., the following circuit at the input of each control pin is recommended. This applies to SPI and control pins 1, 2, 3 and 14 as shown below. Note the recommended resistor and capacitor values do not necessarily match the EV kit BOM for the case of poor control signal integrity. For multiple devices driven by a single control line, the component values will need to be adjusted accordingly so as not to load down the control line.

Figure 48. Control Pin Interface for Signal Integrity


## Evaluation Kit

Figure 49. Top View


Figure 50. Bottom View


## Evaluation Kit / Applications Circuit

Figure 51. Electrical Schematic


Not All Components are used. Please
check the Bill of Material (BOM) table.

Table 10. Bill of Material (BOM)

| Part Reference | QTY | Description | Manufacturer Part \# | Manufacturer |
| :---: | :---: | :---: | :---: | :---: |
| C1, C2 | 2 | 47pF $\pm 5 \%, 50 \mathrm{~V}, \mathrm{COG}$ Ceramic Capacitor (0402) | GRM1555C1H470J | MURATA |
| C3 | 1 | $100 \mathrm{nF} \pm 10 \%, 16 \mathrm{~V}, \mathrm{X7R}$ Ceramic Capacitor (0402) | GRM155R71C104K | MURATA |
| C4 | 1 | 1000pF $\pm 5 \%$, 50V, COG Ceramic Capacitor (0402) | GRM1555C1H102J | MURATA |
| C5, C6, C7 | 3 | $2 \mathrm{pF} \pm 0.1 \mathrm{pF}, 50 \mathrm{~V}, \mathrm{COG}$ Ceramic Capacitor (0402) | GRM1555C1H2R0B | MURATA |
| C12 | 1 | $10 \mu \mathrm{~F} \pm 20 \%, 16 \mathrm{~V}$, X6S Ceramic Capacitor (0603) | GRM188C81C106M | MURATA |
| R1 | 1 | $2.0 \mathrm{k} \Omega \pm 1 \%, 1 / 10 \mathrm{~W}$, Resistor (0402) | ERJ-2RKF2001X | PANASONIC |
| R4-R7 | 4 | OR Resistor (0402) | ERJ-2GE0R00X | PANASONIC |
| R8-R10, R16 | 4 | $1 \mathrm{k} \Omega \pm 1 \%, 1 / 10 \mathrm{~W}$, Resistor (0402) | ERJ-2RKF1001X | PANASONIC |
| J4 | 1 | CONN HEADER VERT SGL $2 \times 1$ POS GOLD | 961102-6404-AR | 3M |
| J6 | 1 | CONN HEADER VERT SGL $3 \times 1$ POS GOLD | 961103-6404-AR | 3M |
| J7 | 1 | CONN HEADER VERT DBL $4 \times 2$ POS GOLD | 67997-108HLF | FCI |
| J1, J2 | 2 | Edge Launch SMA (0.375 inch pitch ground, tab) | 142-0701-851 | Emerson Johnson |
| J3 | 1 | Edge Launch SMA (0.250 inch pitch ground, round) | 142-0711-821 | Emerson Johnson |
| U1 | 1 | VGA AMP | F1451NKGK | RENESAS |
| $\begin{array}{\|c} \text { C8 - C11, C13-C16, } \\ \text { R2, R3, R11-R15, J5 } \end{array}$ |  | DNP |  |  |
|  | 1 | Printed Circuit Board | F145X EVKIT REV 02 |  |

## Evaluation Kit Operation

## Standby

Connector J6 allows the F1451 to be put into the standby mode. Connecting J6 pin 2 (the center pin) to $\mathrm{V}_{\mathrm{cc}}$ the amplifier will be placed in normal operating mode. To put the F1451 into standby mode for very low power consumption ground J6 pin 2 (the center pin). If J6 pin 2 (the center pin) is left open, then the F1451 will default to the standby mode.

Figure 52. Image of J 6 Connector for Standby Mode Control


## Serial Programming Pins

Connector $J 7$ pins $1,2,4,6$, and 8 are ground. Pin 3 is DATA, pin 5 is Clock (CLK), pin 7 is Chip Select (CSB).
Figure 53. Image of J 7 Connector for SPI


## Package Outline Drawings

The package outline drawings are appended at the end of this document and are accessible from the link below. The package information is the most current data available.
www.idt.com/us/en/document/psc/28-vfafpn-package-outline-drawing-60-x-60-x-090-mm-body-07mm-pitch-nkg28p1

## Ordering Information

| Orderable Part Number | Package | MSL Rating | Shipping Packaging | Temperature |
| :---: | :---: | :---: | :---: | :---: |
| F1451NKGK | $6 \times 6 \times 0.9 \mathrm{~mm}$ VFQFPN | 1 | Tray | $-40^{\circ}$ to $0+105^{\circ} \mathrm{C}$ |
| F1451NKGK8 | $6 \times 6 \times 0.9 \mathrm{~mm}$ VFQFPN | 1 | Tape and Reel | $-40^{\circ}$ to $0+105^{\circ} \mathrm{C}$ |
| F1451EVBK | Evaluation Board |  |  |  |
| F1451EVSK | Evaluation Board with Controller |  |  |  |

## Marking Diagram

## Revision History

| Revision Date | Description of Change |
| :---: | :--- |
| January 15,2020 | Extended coverage down to 450MHz. |
| November 29, 2016 | Initial release. |



BOTTOM VIEW

NOTES:
1.ALL DIMENSIONING AND TOLERANCING CONFORM TO ANSI Y14.5M-1982
2. ALL DIMENSIONS ARE IN MILLIMETERS.

28-VFQFPN, Package Outline Drawing
$6.0 \times 6.0 \times 0.90 \mathrm{~mm}$ Body, 0.7 mm Pitch NKG28P1, PSC-4606-01, Rev 00, Page 2


RECOMMENDED LAND PATTERN DIMENSION

NOTES:

1. ALL DIMENSIONS ARE IN MM. ANGLES IN DEGREES.
2. TOP DOWN VIEW, AS VIEWED ON PCB.
3. LAND PATTERN RECOMMENDATION PER IPC-7351B GENERIC REQUIREMENT FOR SURFACE MOUNT DESIGN AND LAND PATTERN.

| Package Revision History |  |  |
| :--- | :--- | :--- |
| Date Created | Rev No. | Description |
|  |  |  |
| May 14, 2019 | Rev 00 | Initial Release |

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